

**Search Notes**

Application/Control No.

10/088,694

Examiner

Jacob Meek

Applicant(s)/Patent under  
Reexamination

HAYATA, TOSHIHIRO

Art Unit

2637

**SEARCHED**

Class	Subclass	Date	Examiner
375	251,143 150, 152 349,142 354,1	11/28/2005	JM
370	342,350	11/28/2005	JM
455	501,63.1	11/28/2005	JM
455	65,67.13	11/28/2005	JM
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370	310,331	11/28/2005	JM
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455	13.4,38.3	12/6/2005	JM
455	67.3	12/6/2005	JM
455	226.3	12/6/2005	JM

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East: see search notes	11/28/2005	JM
NPL	11/28/2005	JM